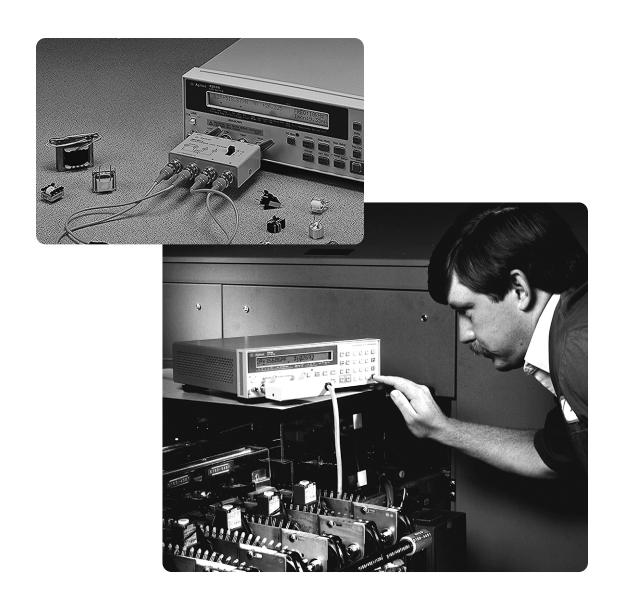


Effective Multi-tap Transformer Measurement using a Scanner and the Agilent 4263B LCR Meter

Application Note 1224-5





Introduction

With the progress of recent electronics equipment and digital networks, production amounts are increasing of the transformers which contribute to equipment miniaturization, low power dissipation and higher quality. Therefore, improvement of select estimate efficiency is required at the production line or incoming inspection. Noticed recently, improvement of estimation efficiency is required for pulse transformers which are used in LAN or ISDN digital networks, and for multi.-tap transformers with three or more pole taps, such as switching power transformers. This application note shows an effective multi-tap transformer measurement using a scanner and the Agilent 4263B LCR meter.

Agilent 4263B Transformer Measurement Capability

The 4263B LCR meter is a low price instrument which measures the fundamental parameters of LCR components with speeds as fast as 25ms, at frequencies of 100, 120, 1k, 10k and 100kHz, In addition, with option 001, the 4263B measures turns ratio (N), mutual inductance (M) and dc resistance (DCR) which are required for transformer measurement. Figure 1 shows a 4263B simple block diagram for L, M, and DCR measurement.

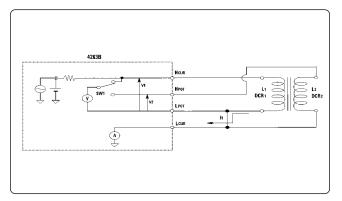
For example, in the inductance-turns ratio (L-N) measurement, an ac voltage is applied at the Hcur terminal. Self-inductance value (L1) is calculated from the measured values of V1 and I1. Turns ratio (N) is automatically obtained from the ratio of measured values V1 and V2 (discriminating the polarity simultaneously).

In the dc resistance (of L-DCR) measurement, the applied voltage at the Hcur terminal is dc. Dc resistance value (DCR1) is calculated from the measured values V1 and I1.

There are, however, the following limitations when using the measurement connection.

- Only primary self-inductance and dc resistance of the transformer can be measured. For the secondary values, the transformer connections must be changed.
- Turns ratio must be 0.9 or more (In the case of less than 0.9, the measurement is not performed due to saturation of internal circuitry).

Agilent 16060A transformer test fixture can be used to overcome these limitations. By changing the external switch of this fixture, connections to the transformer are changed and thus both primary and secondary parameters and turns ratio can easily be measured. Figure 2 shows the simple block diagram of the 16060A.



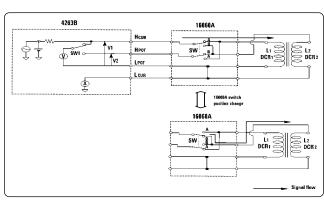


Figure 1. Agilent 4263B block diagram for L, M, and DCR measurement



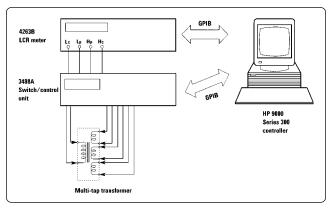
Multi-Tap Transformer Measurement Using a Scanner

Multi-tap transformers having two or more poles can be measured with the 4263B and a scanner.

(A) System configuration

Figure 3 shows the system configuration for measuring a multi-tap transformer that has 4 taps.

The Agilent 3488A switch/control unit with a 4 x 4 matrix switch module (Opt. 013) is used. Option 013 offers highly flexible switching, and any combination of 4 input channels may be connected to any combination of 4 output channels. Thus option 013 is suitable for testing the multi-tap transformer. Figure 4 shows the hardware configuration of the 4 x 4 matrix switch module.



Multi-tap transforme

Figure 3. System configuration for multi-tap transformer

2

14

14

1

5

4 x 4 matrix switch module (Opt. 013) Hiah

_Low

High

Higl

4263B

Row 0

Row 1

Row 2

(B) System construction recommendations

When constructing the system, the following points must be considered to assure the measurements are as precise as can be. (See figure 5)

- 1. Make measurement cables as short as possible. The parasitic inductance and resistance of measurement cables make a large contribution to measurement error. For recommendable length, conductive wire inductance value must be 1/10 or less than the measured inductance value (similarly conductive wire resistance).
- 2. Configure into a shielded 2 terminal configuration, to prevent the influence of external noise or stray capacitance.
- 3. Connect the low terminals close to the transformer. In the 4263B transformer measurement, the primary and secondary inductors' low terminals of the transformer must be connected together. When using a scanner, these connections should be close to the transformer under test. If connecting at a far point from the transformer (for example, input point of scanner module), low side wire resistance would contribute to increase measurement error.

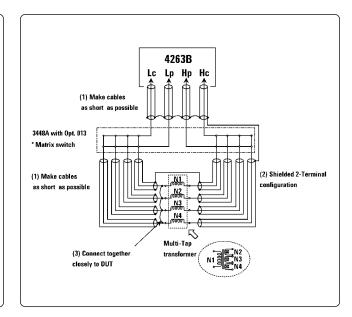


Figure 5. System construction

Figure 4. Option 013 4 x 4 matrix module

h

(C) Measurement procedure

All measurements of the multi-tap transformer, self-inductance, dc resistance, and turns ratio, can be measured with only one connection by using the sample program shown at the end of this note (for HP 9000 Series 300 Controller). Figure 6 show the flow chart of the sample program.

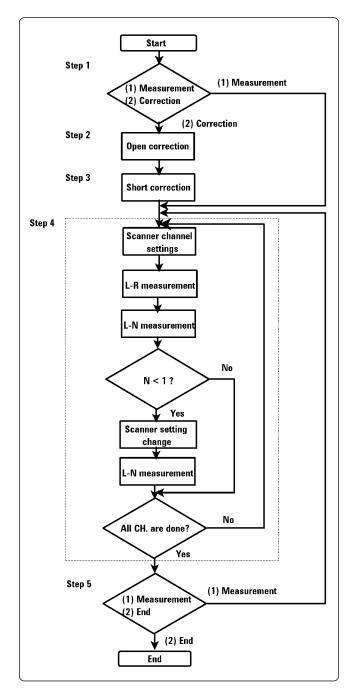
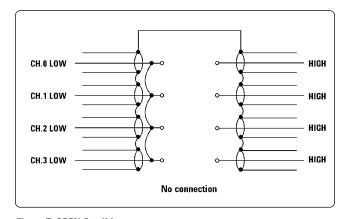


Figure 6. Flow chart of sample program

This program executes the open and short corrections and displays each measured value of each tap of the transformer. If turns ratio measurement cannot be made due to the condition that turns ratio must be 0.9 or greater, the scanner will be automatically changed and the measurements re-done. This program can be modified to match other systems or conditions.

The following steps outline the program procedure:

Step 1. Run the program. The following message is displayed on the controller's display.



Selection (1) Measurement (2) Correction ? Type number and press RETURN key

At this point, select the measurement directly , or first the measurement of correction data. To execute the measurement, type 1 and press RETURN key on the controller (Go to step 4). To measure the correction data, type 2 and press RETURN key on the controller.

Step 2. If the measurement of correction data in step 1 was selected, the following message is displayed on the controller's display. The open correction data of each channel of the scanner (CH.0-CH.3) is now measured.

CH.0 Open measurement Open test terminals of CH.0 Start open meas. (2) Skip CH.0 open meas?

Type number and press RETURN key

To measure the open correction data, set all channels to the open condition as shown in figure 7. Then, type 1 and press RETURN key on the controller. Open correction data of channel number 0 (CH.0) is acquired. Continue to acquire data for channels 1 - 3.



Step 3. After the open correction measurements are completed, the following messages is displayed on the controller's display. The short correction data of each channel of the scanner (CH.0 - CH.3) is now measured.

CH.0 Short measurement Short test terminals of CH.0 Start short meas. (2) Skip CH.0 short meas.?

Type number and press RETURN key

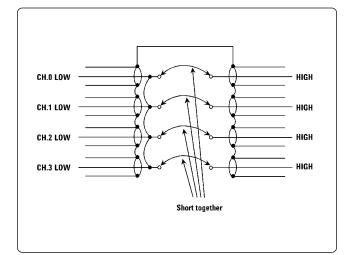
To measure the short correction data, set all channels to short condition as shown in figure 8. Then, type 1 and press the RETURN key on the controller. Short correction data of channel number 0 (CH.0) is acquired. Continue to acquire data for channels 1 - 3.

Step 4. After the open/short correction data is acquired, the following message (same as in step 1) is displayed on the controller's display.

Selection (1) Measurement (2) Correction?

Type number and press RETURN key

To execute the measurement, connect the multi-tap transformer under test to the scanner as shown in figure 9. Type 1 and press the RETURN key on the controller.



Self-inductance, dc resistance and turns ratio are measured by scanning each tap of the multi-tap transformer.

N1: L[H]: 6.00928E-6 DCR [OHM]: .0134568726173 N: 1 N2: L[H]: 2.392557E-5 DCR [OHM]: .0171348134407 N: 2.1304 N3: L[H]: 9.603832E-5 DCR [OHM]: .0230939715609 N: 4.0630 N4: L[H]: .00038334126 DCR [OHM]: .0250939715609 N: 8.0188

Do you want to continue to measure (1) yes (2) no

Step 5. If you want to repeat the measurement, type 1 and press RETURN key on the controller. Or to end the program, type 2 and press RETURN key on the controller.

(D) Additional measurement error

The system configuration shown in figure 3, slightly increases measurement errors, in comparison with measured values using the 16060A transformer test fixture. These errors (supplemental characteristics) are the following using frequency: 1 kHz, signal level: 1 Vrms, measurement time: Medium.

> Self-inductance: refer to figure 10 Dc resistance: refer to figure 11 Turns ratio: 0.02 % or less

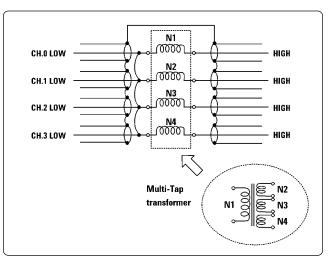


Figure 9. Connection of multi-tap transformer

Figure 8. SHORT Condition



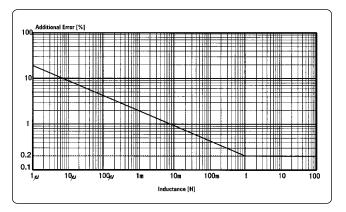


Figure 10 . Self-Inductance additional error

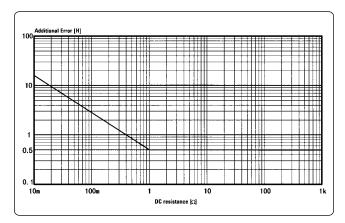


Figure 11. Dc resistance additional error

Conclusion

By combining the Agilent 4263B (with Option 001) with a scanner, the required parameters of a multi-tap transformer can be measured with only one connection. Using this method improves efficiency at the production line or incoming inspection.

```
4263B GPIB Address = 717
3488A GPIB Address = 709
(#-1) of Transformer tap
Test Frequency
Test Signal Level
Measurement Speed
N1=1 as reference
                                                                                                                                                           << MAIN MEMU >>
                   PRINT CHR$(12)
Work=0
PRINT "SELECT FUNCTION (1) MEASUREMENT (2) CORRECTION ?" !
INPUT "TYPE NUMBER AND PRESS RETURN KEY", Work !
IF Work=1 THEN Measurement
IF Work=2 THEN Correction
                                                                                                                                                           << CORRECTION >>
               Open_correction:
                                                                                                                                                           << OPEN correction >>
                   OUTPU1 4263B;":SYSTEM:PRESET"
OUTPU1 4263B;":SOURCE:FREQ ";F
OUTPU1 4263B;":SOURCE:VOLTAGE ";V
OUTPU1 4263B;":SENS:FIMP:APER 0.5"
                                                                                                                                                           Reset the 4263B
Frequency: F
Signal level: V
Meas. speed: LONG
                     FOR Ch=0 TO Nch
                         Ch$=vAL$(Ch)

PRINT CHR$(12)

PRINT "CH."&Ch$&" OPEN MEASUREMENT"

IF Ch-O THEN PRINT "OPEN TEST TERMINALS OF CH.O AND CH.1"!

IF Ch-C+>O THEN PRINT "OPEN TEST TERMINALS OF CH.0 AND CH."&Ch$!

PRINT " (1) START OPEN MEAS. (2) SKIP CH."&Ch$&" OPEN MEAS.?"

UA-vE-0
                         PRINT "(1) START OPEN MEAS. (2) SKIP UH."&U
Work=0
INPUT "TYPE NUMBER AND PRESS RETURN KEY",Work !
IF Work<>1 AND Work<>2 THEN 460 !
IF Work=1 THEN Open_meas !
IF Work=2 THEN Open_skip_ch
                          Ch_hc(Ch)=200+Ch*10
IF Ch=0 THEN Ch_hp(Ch)=211
IF Ch<>0 THEN Ch_hp(Ch)=201
                                                                                                                                                            Channel Setting of Hcur/Lcur
Channel Setting of Hpot/Lcur
                        IF CH<PU T4688; "RESET"

OUTPUT 34888; "CLOSE":Ch_hc(Ch), Ch_hp(Ch)

OUTPUT 42638; ":SENS:FUNC:CONC ON"

OUTPUT 42638; ":SENS:FUNC:TMP', 'RES'"

OUTPUT 42638; ":CALC1:FORM LS"

OUTPUT 42638; ":CALC2:FORM REAL"

INTER 42638; Open_L(Ch), Open_r(Ch)

IF 5<>0 THEN 640

OUTPUT 3488a; "OPEN";Ch_hc(Ch), Ch_hp(Ch)

Open_g(Ch)=1/Open_l(Ch)
                                                                                                                                                           Reset the 3488A
! Close the channels
Meas.mode: L2-R2
                                                                                                                                                            Trigger mode: BUS
OPEN correction data
                                                                                                                                                               ! Open the channels
                                                                                                                                                             << SHORT Correction >>
                    OUTPUT 4263B;":SYSTEM:PRESET"
OUTPUT 4263B;":SOURCE:FREQ ";F
OUTPUT 4263B;":SOURCE:VOLTAGE ";V
OUTPUT 4263B;":SENS:FIMP:APER 0.5"
                                                                                                                                                             Reset the 4263B
                                                                                                                                                               Frequency: F
Signal level: V
Meas, speed: LONG
                     FOR Ch=0 TO Nch
                           PRINT CHR$(12)
                                                                                                                                                           Clear screen

      PRINT CHR$(12)
      ! Clear screen

      Chs=valsCch)
      ! Clear screen

      PRINT "CH."&Ch$&" SHORT MEASUREMENT" !

      IF ch=0 THEN PRINT "SHORT TEST TERMINALS OF CH.0 AND CH.1"!

      IF ch>0 THEN PRINT "SHORT TEST TERMINALS OF CH.0 AND CH."&Ch$ !

      PRINT "(1) START SHORT MEAS. (2) SKIP CH."&Ch$&" SHORT MEAS.?" !

      Vork=0

      INPUT "TYPE NUMBER AND PRESS RETURN KEY", Work !

      IF Work<1 THEN Short_meas</td>

      IF Work=2 THEN Short_skip_ch
```

Short_meas: Ch hc(Ch)=200+Ch*10	I Channel Satting for Moun/Lour
IF Ch=0 THEN Ch hp(Ch)=211 0 IF Ch<>0 THEN Ch_hp(Ch)=201	! Channel Setting for Hcur/Lcur ! Channel Setting for Hpot/Lpot !
0 OUTPUT 3488a; "RESET"	! Reset the 3488A
0 OUTPUT 3488a; "CLOSE"; Ch_hc(Ch), Ch_hp(Ch 0 OUTPUT 4263B; ":SENS: FUNC: CONC_ON"	<pre>! Close the channels ! Meas.mode: L2-R2</pre>
0 OUTPUT 4263B;":SENS:FUNC 'IMP', 'RES'" 0 OUTPUT 4263B;":CALC1:FORM LS"	1
0 OUTPUT 4263B; ":CALC2:FORM REAL"	1
0 OUTPUT 4263B; "TRIG: SOUR BUS" 0 OUTPUT 4263B: "*TRG"	! Irigger mode: BUS ! SHORT correction data
0 ENTER 4263B;S,Short_l(Ch),Short_r(Ch) 0 IF S<>0 THEN 1090	1
)! Open the channels
0 Short_skip_ch:	1
0 _ / _ /	1
0	i I Return to Main Menu
0 GOTO Main_menu 0	!
0 Measurement: 0	! << MEASUREMENT >> !
	! Clear screen ! Reset the 4263B
0 OUTPUT 4263B;":SYSTEM:PRESET" 0 OUTPUT 4263B;":SOURCE:FREQ ";F 0 OUTPUT 4263B;":SOURCE:VOLTAGE ";V 0 OUTPUT 4263B;":SOURCE:VOLTAGE ";V	Frequency: F
0 OUTPUT 4263B;":SOURCE:VOLTAGE ";V 0 OUTPUT 4263B;":SENS:FIMP:APER ";T	I Teset signal level: V Measurement Speed: T
0 OUTPUT 4263B; ":SENS:FIMP:APER ";T 0 OUTPUT 4263B; ":TRIG:SOUR BUS" 0 OUTPUT 3488a; "RESET"	! Trigger mode: BUS ! Reset the 3488A
U	
0 FOR Ch=0 TO NCh 0 0 OUTPUT 4263B;":SENS:FUNC:CONC ON"	
0 OUTPUT 4263B;":SENS:FUNC:CONC ON" 0 OUTPUT 4263B;":SENS:FUNC 'IMP', 'RES'"	! Meas.mode: L2-R2 !
0 OUTPUT 4263B; ":SENS:FUNC 'IMP', 'RES'" 0 OUTPUT 4263B; ":CALC1:FORM LS" 0 OUTPUT 4263B; ":CALC2:FORM REAL"	!
0 OUTPUT 4263B;":CALC2:FORM REAL" 0 Ch_hc(Ch)=200+Ch*10	: ! Channel Setting for Hcur/Lcur ! Channel Setting for Hpot/Lpot
0 Ch hc(Ch)=200+Ch*10 0 IF Ch=0 THEN Ch hp(Ch)=211 0 IF Ch<>0 THEN Ch hp(Ch)=201	1
<pre>0 OUTPUT 3488a;"CLOSE";Ch_hc(Ch),Ch_hp(C) 0 OUTPUT 4263B;"*TRG"</pre>	h)! Close the channels
0 ENTER 4263B;S,Meas_L(Ch),Meas_r(Ch) 0 True_L(Ch)=(Meas_L(Ch)-Short_L(Ch))/((
 OUTUT 3488a; "CLOSE"; Ch_hc(Ch), Ch_hp (C) OUTUT 3488a; "CLOSE"; Ch_hc(Ch), Ch_hp (C) OUTUT 4258; WHRG" ENTER 4258; SHeas_((Ch), Meas_r(Ch)) True_l(Ch)=(Meas_r(Ch)-Short_r(Ch))/((C)) True_r(Ch)=(Meas_r(Ch)-Short_r(Ch))/((C)) 	1-(Meas_l(Ch)-Short_l(Ch))*Open_b(Ch) 1-(Meas_r(Ch)-Short_r(Ch))*Open_g(Ch)
0 IF Ch=0 THEN Skip_meas	
0 0 0 OUTPUT 4263B;":SENS:FUNC 'IMP','VOLT:AC	i Nu I Meas mode: I-N
0 OUTPUT 4263B; "*TRG"	! N measurement
0 ENTER 717;S,Dummmy(Ch),N(Ch) 0	1 1
0	! Hour-Hoot CHANGE for OVLD
0 Ch_hc(Ch)=201+Ch*10	! Hour channel CHANGE
0 Ch ⁻ hp(Ch)=200 0 OUTPUT 3488a;"CLOSE";Ch_hc(Ch),Ch_hp	! Hpot channel CHANGE (Ch) ! Close the changed ch.
0 OUTPUT 4263B; "*TRG"	! N measurement
0 ENTER 4263B;S,Dummmy(Ch),N(Ch) 0 N(Ch)=N(O)/N(Ch)	N1:Nx=1:0.XX
0 END IF	1
0 Skip_meas: 0	!
0 PRINT "N";Ch+1;":","L [H]:";True l(Ch) 0 OUTPUT 3488a;"OPEN";Ch hc(Ch),Ch hp(Ch	
0 NEXT Ch 0 NEXT Ch	
0 Work=0	
0 INPUT "DO YOU WANT TO CONTINUE TO MEASUR 0 IF Work=1 THEN Measurement	E? (1) TES (2) NU",WORK !
0 IF Work=2 THEN 1740	1
0 IF Work<>1 AND Work<>2 THEN 1690 0	

By internet, phone, or fax, get assistance with all your test and measurement needs

Online assistance:

www.agilent.com/find/assist

Phone or Fax:

United States: (tel) 1-800-452-4844

Canada: (tel) 1-877- 894-4414 (fax) (905) 282-6495

China: (tel) 800-810-0189 (fax) 1-0800-650-0121

Europe: (tel) (31 20) 547-2323 (fax) (31 20) 547-2390

Japan: (tel) (81) 426-56-7832 (fax) (81) 426-56-7840

Korea: (tel) (82 2) 2004-5004 (fax) (82 2) 2004-5115

Latin America: (tel) (305) 269-7500 (fax) (305) 269-7599

Other Asia Pacific Countries: (tel) (65) 375-8100 (fax) (65) 836-0252 Email: tm_asia@agilent.com

Product specifications and descriptions in this document subject to change without notice.

© Agilent Technologies, Inc. 1992, 2001 Printed in U.S.A., November 5, 2001 5091-6310E

